

Temperature Correction Using Degenerate Modes for Cylindrical Cavity Perturbation Measurements

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Abstract—Microwave cavity perturbation measurements are a useful way to analyze material properties. Temperature changes can be introduced during these measurements either intentionally or as a result of some other process. The microwave cavity itself also has a temperature-dependent response, which can affect the results. A common method to correct is to use another resonant mode separately to the measurement mode, which is not affected by the sample. Instead of using independent modes, this paper describes a method to use split degenerate TM_{m10} modes of cylindrical cavities. TM_{m10} consists of two modes with identical field patterns with a relative rotation between them and identical resonant frequencies. A strategically placed perturbation reduces the frequency of one of the TM_{m10} modes and affects the coupling of both modes by reconfiguring the fields. This can be used for temperature correction by placing a sample such that both modes are equally coupled. The lower frequency, the perturbed mode is used as a measurement mode. The higher mode is used as a reference for temperature correction as it is unaffected by the sample. This technique was verified by measuring the permittivity of pure water using an aluminum microwave cavity resonator at 3.96 GHz. The temperature was swept between 20 °C and 60 °C, and the results was verified against the literature.

Index Terms—Cavity resonators, dielectric characterization, microwave measurement, permittivity, perturbation methods.

I. INTRODUCTION

THE microwave cavity perturbation technique is a commonly used method of defining electromagnetic properties of materials due to its noninvasive and nondestructive qualities [1]–[5]. This technique involves perturbing a resonant electromagnetic field with a sample and measuring the change in the frequency response. Many measurements carried out with the microwave perturbation technique involve a change in temperature such as environmental changes or exothermic/endergonic chemical reactions within the sample [6]–[9]. Alternatively, the change can be intentional while examining dielectric properties over a range of temperatures. As the measured resonant frequency and bandwidth of the cavity are a function of the cavity geometry, a method of decoupling changes due to cavity expansion/contraction from the changes in sample dielectric properties is essential.

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All cylindrical cavities have modes that can be considered degenerate. Degenerate modes occur when the two cavity modes have the same resonant frequency. Mode degeneracy can have two different causes. The roots of Bessel functions that define two different modes can force the frequencies to be equal, for example, cylindrical modes TM_{111} and TE_{011} [since $J'_0(x) = -J_1(x)$] [10]. Alternatively, degenerate modes can occur when the rotational symmetry of the mode allows different possible orientations such as cylindrical mode TM_{m10} (where $m \geq 1$) [10].

Assuming a perfectly constructed microwave cavity, these degenerate modes would have exactly the same resonant frequency. In practice, inevitable small imperfections in the cavity construction can cause these modes to have slightly different resonant frequencies. By inserting a sample away from the central axis of the cavity, it is possible to separate the resonant frequencies of the modes. This is often referred to as a mode trap [7], [11]. Perturbing the cavity fields causes the orientation of one of the possible modes to align with a local maximum at the sample. The other mode would have a local minimum. This sample can be placed at a location to suppress the degenerate mode, by ensuring that it is not coupled to. Alternatively, the sample can be placed at a location such that both orientations are equally coupled. Hence it is possible to use equally coupled, split degenerate modes to correct for changes in temperature during perturbation measurements. The main advantage of the proposed method is the much narrower bandwidth compared with using a nondegenerate reference mode. This is described in Section III-A, for example, TM_{310} at 6.62 GHz can be used as a reference for measurements using TM_{010} at 2.50 GHz, leading to a wide bandwidth. This proposed method dramatically simplifies the instrumentation for dielectric sensor applications, where a measurement bandwidth of less than 100 MHz will suffice. A further advantage is a reduction in other systematic errors, such as variations in the coupling coefficients as a function of frequency.

II. SPLITTING THE DEGENERACY OF TM_{m10} MODES

TM_{mnp} modes are described by the integers m , n , and p , where m is the azimuthal periodicity, n is the number of Bessel function maxima between the axis and circumference, and p is the number of nodes in the z -direction. The axial electric field amplitude (E_z) is described by (1) derived from [12]

$$E_z(r, \phi, z) = E_0 J_m \left(\frac{k_{mn} r}{a} \right) \cos(m(\phi + \theta)) \cos \left(\frac{p\pi z}{l} \right) \quad (1)$$

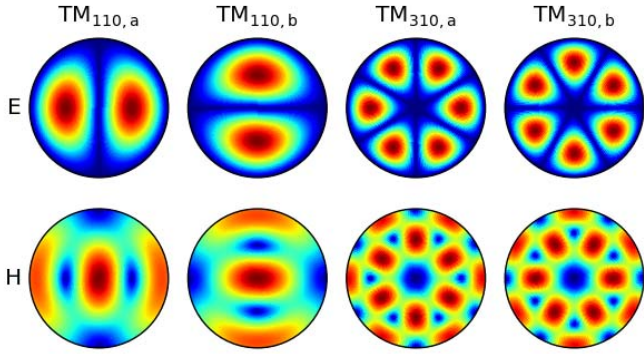


Fig. 1. Electric field (E) and magnetic field (H) patterns for the degenerate $TM_{110,a}$, $TM_{110,b}$, $TM_{310,a}$, and $TM_{310,b}$ modes.

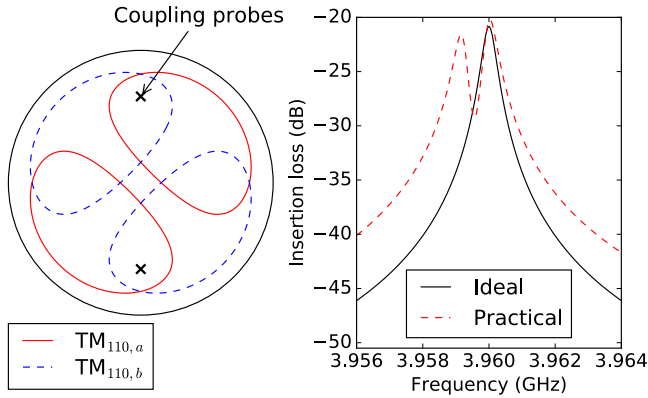


Fig. 2. Schematic contour plot of the electric field magnitude for the TM_{110} mode with capacitive (i.e., E-field) coupling probes, located as shown for a transmission measurement (left). Measured transmitted power $|S_{21}|^2$ in the frequency domain of the TM_{110} mode in a cavity split in the vertical plane in the ideal case (black solid line) and in the practical case (red dashed line).

where a is the cavity radius, l is the cavity height, θ is the axial rotation (resulting in the $TM_{m10,a}$ and $TM_{m10,b}$ variants), and k_{mn} is the n th root of the m th-order Bessel function of the first kind. The field patterns of these modes are shown in Fig. 1.

With a perfectly symmetrical cylindrical microwave cavity, the spatial orientations of the TM_{m10} modes result in exactly the same frequency, thus yielding a single Lorentzian response. Distortion or splitting of the Lorentzian response can occur when the frequencies are unequal. This can happen when the azimuthal symmetry of the cylindrical cavity is broken, such as with a split in the cavity construction in the vertical plane, or where there are holes in the cavity. These ideal and practical scenarios can be seen in Fig. 2 along with the orientation of $TM_{110,a}$ and $TM_{110,b}$ modes.

In the practical scenario, it is difficult to extract Lorentzian curve parameters from the TM_{110} mode due to the distortion of the Lorentzian peak. A perturbation can be positioned to maintain equal coupling between the two modes while also increasing separation between the $TM_{110,a}$ and $TM_{110,b}$ modes. If the perturbation is large enough to ensure sufficient separation, then the unperturbed TM_{110} mode can be used for temperature correction. This is discussed in Section III-B.

III. TEMPERATURE CORRECTION USING SPLIT DEGENERATE MODES

Many microwave cavity perturbation measurements involve a change in temperature of the measurement cavity. Regardless of the reason behind it, a change in cavity temperature causes several changes to the host cavity that affect the frequency response of the system; change in cavity geometry, coupling geometry, and temperature-dependent electrical conductivity of the cavity walls. These temperature changes during microwave perturbation measurements cause changes in measured frequency. This must be accounted for so that any changes in the resonant frequency are caused by changes in the sample.

A. Method of Temperature Correction and Measurement

Previously, temperature correction has been carried out using two-independent modes [13], [14]. One mode is used to measure the sample, most frequently an axially placed sample measured using one of the TM_{0n0} modes. This mode is chosen as the electric field and can be assumed to be constant over the sample volume with a high electric field and negligible magnetic field at the location of the sample. A second mode is chosen which has no electric or magnetic field at the location of the sample. For axially placed samples, this is often one of the TM_{m10} modes, where $m \geq 1$. The sample will have no effect on the frequency response of this mode, meaning measured changes can be assumed to be from the temperature response of the cavity. These choices allow the measurement mode to be sensitive to the sample while the reference mode allows for temperature correction.

Using the microwave characterization technique, the measured resonant frequency f_0 can be calculated using the following:

$$f_0 = \frac{c}{2\pi} \sqrt{\left(\frac{k_{mn}}{a(T)}\right)^2 + \left(\frac{p\pi}{l(T)}\right)^2} \quad (2)$$

where c is the speed of light, n , m , and p are the mode integers, k_{mn} is the n th root of the m th-order Bessel function of the first kind, and $a(T)$ and $l(T)$ are the temperature-dependent radius and height of the cavity, respectively. As the cavity undergoes a change in temperature, this causes a change in the geometry of the cavity. As described in [13] and [14], by using first-order partial derivatives, the changes in resonant frequency due to a change in temperature can be seen as follows:

$$\frac{\Delta f_0}{f_0} \approx -\alpha_c \Delta T \quad (3)$$

where ΔT is the change in temperature and α_c is the linear thermal expansion coefficient. This equation only accounts for changes in the cavity geometry—the main source of temperature-dependent error.

Equation (4) is used to correct the frequency measurements for temperature changes [13], [14]

$$\frac{\Delta f_s(T)}{f_s(0)} \approx \left[\frac{\Delta f_{010,s}(T)}{f_{010,s}(0)} - \frac{\Delta f_{m10,s}(T)}{f_{m10,s}(0)} \right] - \left[\frac{\Delta f_{010,u}(T)}{f_{010,u}(0)} - \frac{\Delta f_{m10,u}(T)}{f_{m10,u}(0)} \right] \quad (4)$$

where u represents the unperturbed cavity and s when the sample is present. As (3) suggests, any change in temperature causes a proportional change in resonant frequency of the cavity. This change in frequency has the same fractional shift for an ideal cavity regardless of cavity mode. When the sample is present, the frequency can be corrected by subtracting the fractional frequency shift of the reference mode from the fractional frequency shift of the measurement mode. This can be seen in the sample related terms in (4). The unperturbed terms of this equation are included to remove any errors caused by differences in gradient from the thermal expansion coefficient. These differences are caused by imperfections in the cavity construction and material.

With corrected frequency measurements, the values for real permittivity can then be calculated using the following:

$$\varepsilon_1(T) \approx -2 \left[\frac{f_s(T) - f_0(0)}{f_0(0)} \right] \frac{V_c}{V_s} G_{mnp} + 1 \quad (5)$$

where V_c and V_s are the cavity and sample volumes, respectively. The dimensionless geometry factor G_{mnp} can be calculated by placing a known sample into the cavity, such as a quartz rod, and verified by simulation (e.g., COMSOL) or through analytical calculations. As this method uses an intermodal relationship between cavity modes, no previous measurements of expansion coefficients are required [13], [14].

B. Proposed Use of Degenerate Modes

Degenerate modes, as discussed in Section II, can be used as an alternative method for correcting the temperature changes. This method uses the same analysis, as discussed in Section III-A. When a sample is inserted into the cavity off-axis, this causes degenerate modes to split. The placement of the sample must be chosen to ensure both modes are equally coupled. For modes TM_{110} and TM_{310} used in this paper, the sample is inserted at an angle of 45° from the coupling structures, however, this results in TM_{210} and TM_{410} being unusable. This is shown in Fig. 3.

This perturbation locks the orientation of the modes. One of the modes will be perturbed by the sample and thus will have a lower frequency. This lower frequency mode becomes the measurement mode and is referred to as $TM_{m10,a}$. The higher frequency of the two modes will not be affected by the introduction of the perturbing sample. This unaffected mode becomes the reference mode and is used for temperature corrections. This mode is referred to as $TM_{m10,b}$.

Due to the geometry of the modes, not all of them can be coupled equally at once. Placing the sample at 45° from the coupling probes allows the use of the TM_{110} and TM_{310} modes. TM_{210} and TM_{410} are unusable due to only coupling the unperturbed and perturbed modes, respectively. The technique used in Section III-A is utilized to correct for temperature while replacing TM_{010} and TM_{m10} modes in (4), with $TM_{m10,a}$ and $TM_{m10,b}$ modes, respectively.

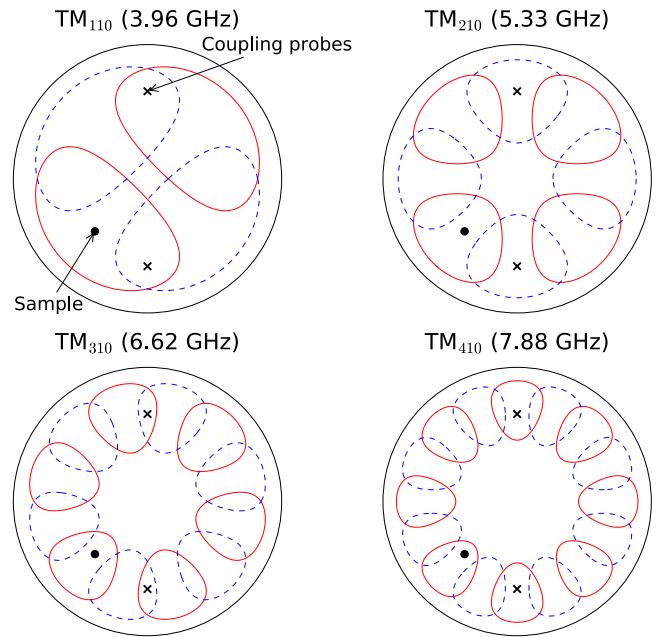


Fig. 3. Contour plots of TM_{m10} modes. TM_{110} and TM_{310} have equal coupling between the perturbed and unperturbed modes. Only the unperturbed TM_{210} mode is coupled, and only the perturbed TM_{410} mode is coupled.

Using this technique, the sample is placed in the region of the high electric field and notionally zero magnetic field of the measurement mode $TM_{m10,a}$. When considering the fields of the reference mode $TM_{m10,b}$, the sample is in a region of the low electric field but a high magnetic field. As described in Section III-A, in order for this technique to work for any material, the reference mode must have no magnetic of the electric field at the sample location. Due to this the degenerate mode, temperature correction technique described may only be used on the samples, which are nonmagnetic.

IV. METHOD AND RESULTS

These experiments were conducted using an aluminum microwave cavity resonator designed for TM measurements with capacitive antenna coupling into the E-field. Measurements were taken using the TM_{110} mode configuration shown in Fig. 3. The TM_{310} mode was not used due to interference from another mode with similar resonant frequency.

The temperature was controlled by placing the resonant cavity in a Memmert IPP400 temperature controlled oven. The transmission (S_{21}) measurements were obtained using Keysight Technologies Vector Network Analyzer (VNA) (PNA-L N5232A) with RF cables from Huber+Suhner. The VNA was connected to a PC running an in-house measurement acquisition program built with LabVIEW. The program also measures the temperature of the cavity using an Omega PT100 temperature sensor connected to a National Instruments (NI) cDAQ-9171. This is shown in Fig. 4.

The experiment consisted of two temperature ramp measurements, one with empty quartz tubes and the other with the addition of a water sample. Two nested quartz tubes were used. The outer tube has an outer diameter of 4.0 mm

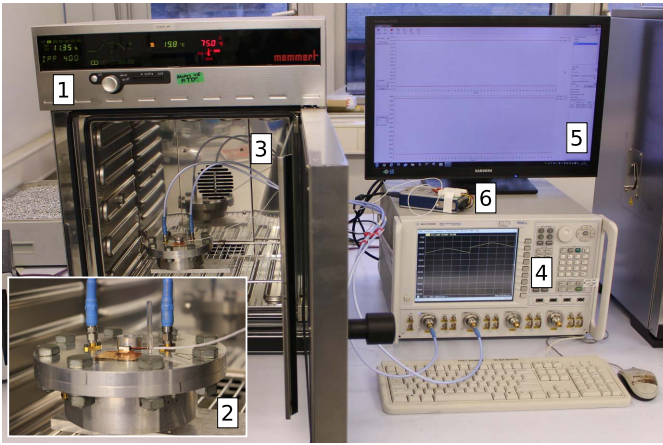


Fig. 4. (1) Experimental setup showing the temperature controlled oven (2) containing the microwave cavity resonator with the inserted sample and attached temperature sensor. (3) Coaxial cables (4) connect the cavity to the VNA, which is being driven by (5) LabVIEW measurement acquisition program. (6) Temperature sensor is connected to the NI-DAQ, also controlled by the same program.

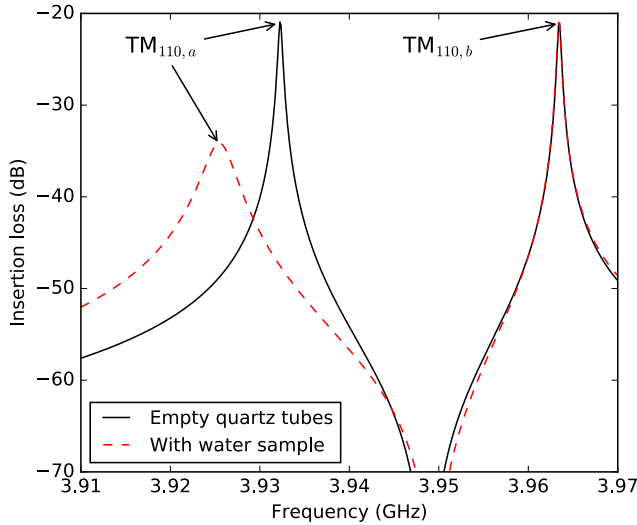


Fig. 5. Measured transmitted power $|S_{21}|^2$ in the frequency domain of the TM_{110} mode when perturbed by the empty quartz tubes (black solid line) and when a water sample is added (red dashed line).

and the inner diameter of 2.0 mm. The inner tube has an outer diameter of 0.4 mm and the inner diameter of 0.3 mm. The purpose of the outer tube was to split the high and low TM_{110} modes enough to treat them as separate modes and reliably extract the frequency and Q -factor. The inner tube is used as a container for a small volume of water. The frequency response showing the separation of these modes can be seen with and without the water sample in Fig. 5.

The temperature ramps were performed from 20 °C to 60 °C over 8 h, then returning to 20 °C at the same rate. Both the measurement mode $TM_{110,a}$ and reference mode $TM_{110,b}$ were measured for the empty and water ramps. The frequency results of these measurements are shown in Fig. 6.

Frequency results show the reference mode $TM_{110,b}$ is not affected by the presence of the sample, as described

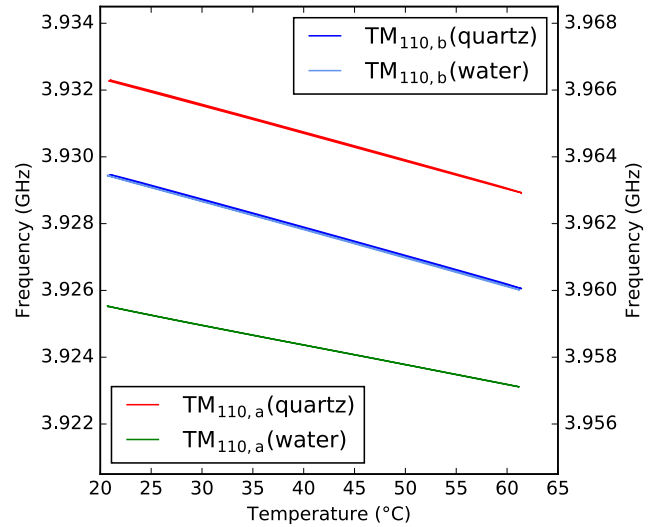


Fig. 6. TM_{110} measured frequency versus temperature with measurement modes on the left axis and reference modes on the right axis.

in Section III-B. The measurements for the $TM_{110,a}$ mode have different resonant frequencies for water and quartz due to the addition of water affecting the perturbation. These measurement modes also have different gradients. The gradient in the quartz tubes is caused predominantly by the change in cavity temperature as the permittivity of quartz has very little temperature dependence. The gradient of the water containing sample has the same contribution from the temperature change of the cavity and quartz, but also a contribution due to the temperature dependence of permittivity for water. Before temperature correction of the water sample, the frequency decreases as the temperature increases. This trend is the opposite of the expected result. To resolve this, the temperature correction technique explained in Section III-B is used to remove the contributions from the cavity and quartz tubes, as well as reduce the errors present. This method ensures that after correcting these values, the only changes in observed frequency are due to changes in the permittivity of water. The real permittivity of water is calculated using (5) before and after temperature correction of frequency has been carried out. This can be seen in Fig. 7.

Real permittivity values shown in Fig. 7 show that before temperature correction the graph suggests a rise in permittivity of the water sample as temperature increases. Once this data has been corrected, a decrease in real permittivity can be seen between 20 °C and 60 °C. This corrected negative gradient and corresponding ϵ_1 values now closely match the literature values calculated from the equations developed by Kaatz [15]. This also matches closely with the values seen in the literature [16], [17]. The errors for these measurements were also calculated and compared with the literature values, as shown in Table I.

The main systematic errors accounted for include the permittivity and volume of the calibration quartz rod, and the volume of the water sample. These are approximately 2%. The random errors were negligible in comparison, less than 0.1%. As the table shows, the experimental results were well within

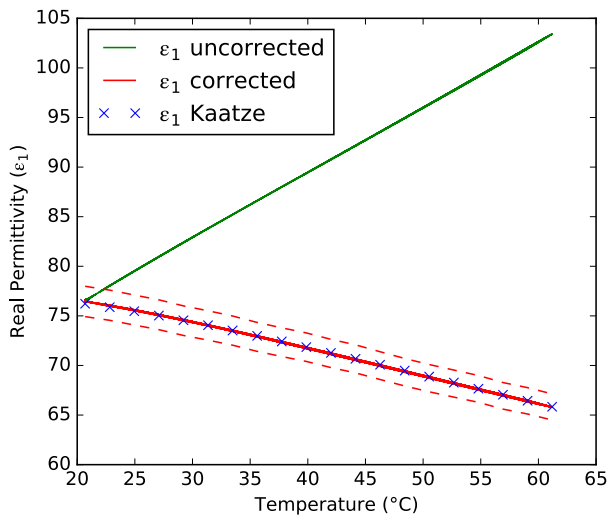


Fig. 7. Corrected, uncorrected, and literature values for real permittivity (ϵ_1) of water at 4 GHz versus temperature with 2% systematic error (dotted lines).

TABLE I

COMPARISON OF EXPERIMENTAL MEASUREMENTS VERSUS LITERATURE VALUES OF THE PERMITTIVITY OF WATER AT 4 GHz

T (°C)	$\epsilon_{1,Kaatze}$	$\epsilon_{1,measured}$	Percentage difference
25.0	75.46	75.54	0.11%
30.0	74.37	74.43	0.08%
35.0	73.14	73.04	-0.13%
40.0	71.82	71.67	-0.21%
45.0	70.44	70.27	-0.24%
50.0	69.03	68.91	-0.17%
55.0	67.60	67.49	-0.17%
60.0	66.18	66.18	0.01%

the systematic error when compared against the literature permittivity values.

V. CONCLUSION

Temperature correction was carried out on cavity perturbation measurements by splitting degenerate modes and using one as a robust and precise reference. This paper shows that degenerate TM_{m10} modes can be reconfigured by perturbing the cavity. This is useful to prevent the interference between the higher and lower frequency TM_{m10} modes. The position of the mode relative to the cavity coupling structures determines how strongly that mode is coupled.

The use of TM_{m10} modes is applied to the temperature correction technique developed by Cuenca *et al.* [13]. This technique is required due to the temperature-dependent properties of the microwave cavity. The sample is placed in a position to ensure equal coupling of both TM_{m10} modes. The lower frequency perturbed mode is used to measure the sample, and the higher mode is used as a reference unaffected by the sample.

To verify this technique, the temperature-dependent properties of the water were investigated. Before correction, the frequency response of the water sample appears to be incorrect

due to the dominating temperature-dependent properties of the microwave cavity. After temperature correction, the values were verified against the literature and confirmed to be accurate.

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Information about the data underpinning the results presented here, including how to access them, can be found in the Cardiff University Data Catalogue at <http://doi.org/10.17035/d.2018.0050743125>.

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